

<b>Notice of References Cited</b>	Application/Control No. 10/585,225	Applicant(s)/Patent Under Reexamination WONG ET AL.	
	Examiner AKLIL TESFAYE	Art Unit 2423	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0195866	08-2006	Thukral, Vivek	725/034
*	B	US-2002/0100042	07-2002	Khoo et al.	725/34
*	C	US-2002/0083444	06-2002	Blasko et al.	725/35
*	D	US-2003/0229893	12-2003	Sgaraglino, Vito	725/37
*	E	US-2002/0078441	06-2002	Drake et al.	725/9
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

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